

**Search Notes**

Application/Control No.

10/682,250

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under  
Reexamination

AKAMINE ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	129	1/22/2006	NKV
330	133	12/29/2004	NKV
330	134	12/30/2004	NKV
330	279	12/29/2004	NKV
330	285	12/29/2004	NKV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See Search History Printout		1/22/2006	NKV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	1/22/2006	NKV